

原子力显微测试数据



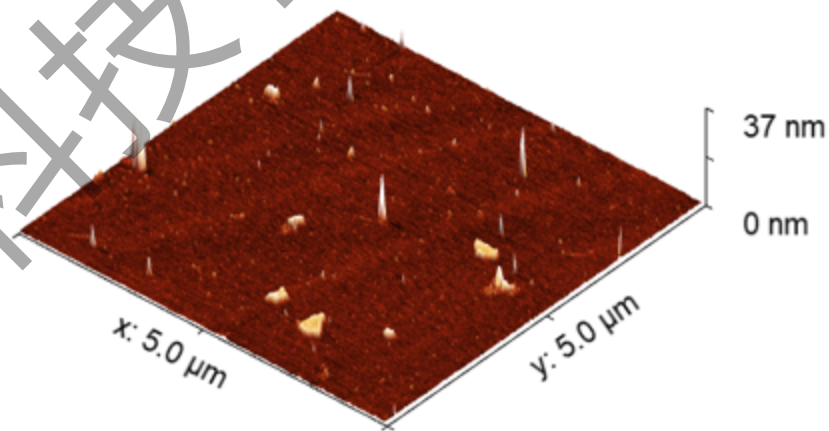
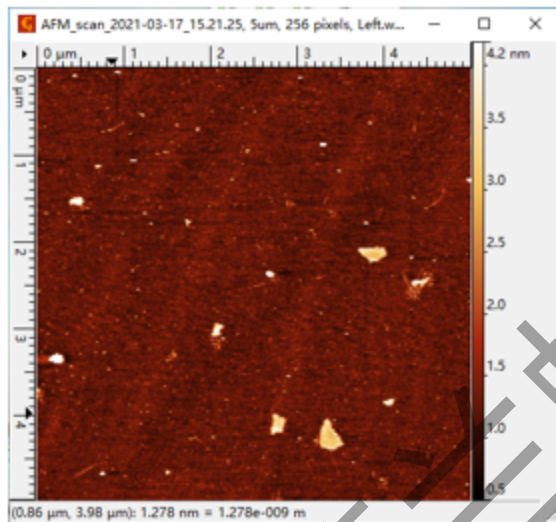
样品单位：江苏科技大学

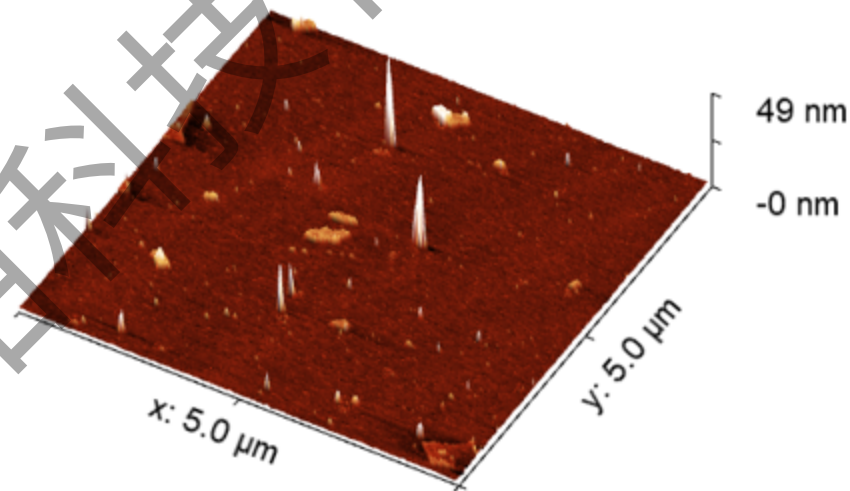
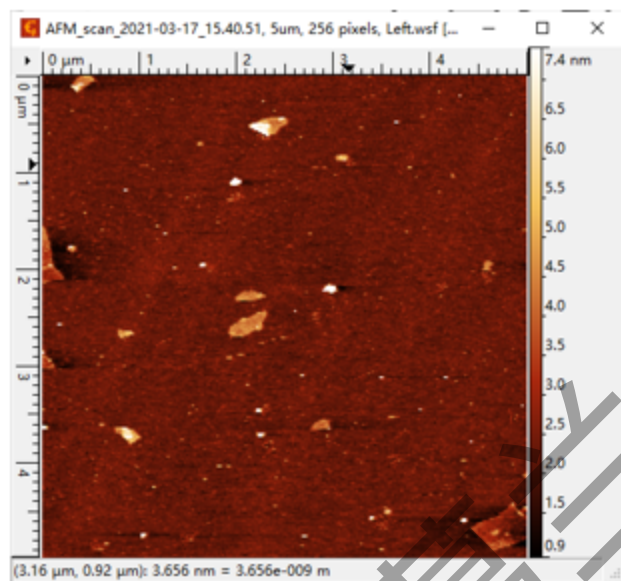
测试工程师：言峰

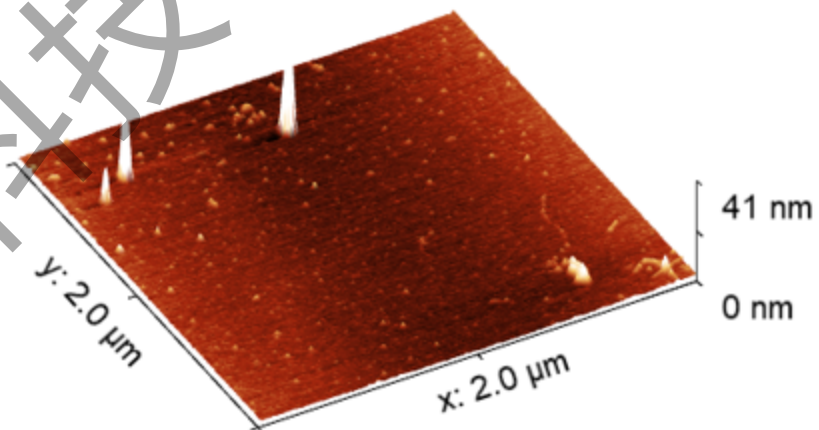
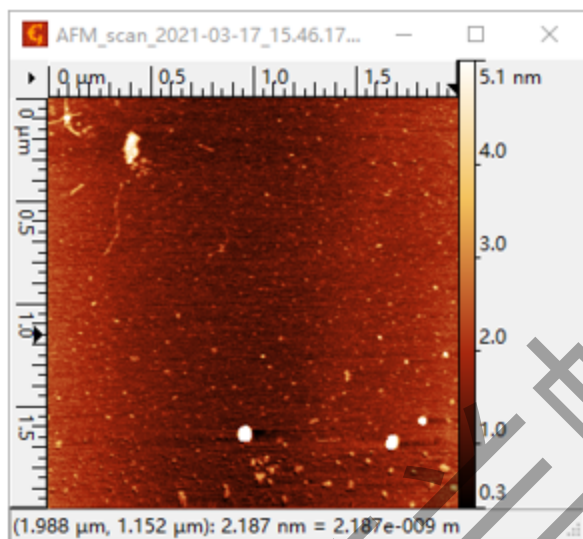
本次测试选用探针：Nanoworld品牌 RTESSPA-300

本文由[原子力显微镜](#),[扫描探针显微镜](#),[AFMworkshop](#),[杭州葛兰帕科技](#)发布, 未经本站允许, 不得转载。

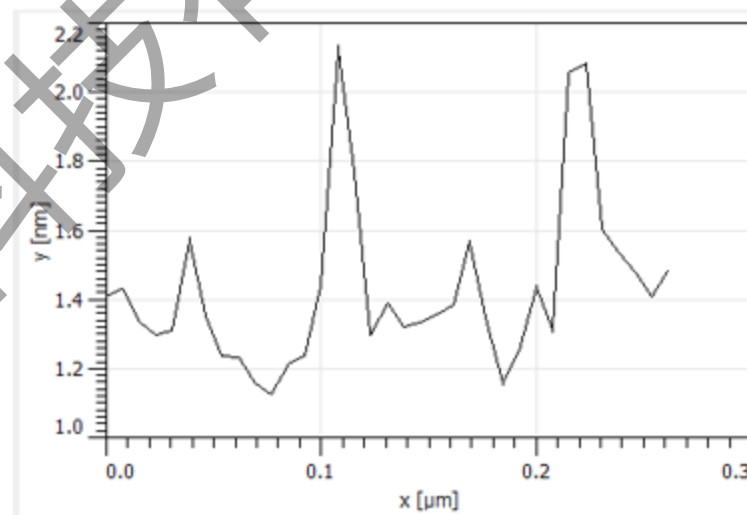
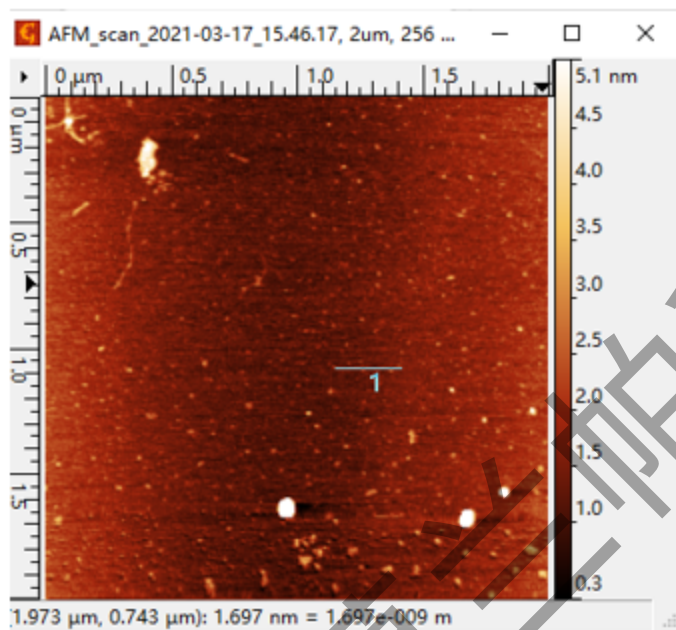
5um GO sample test





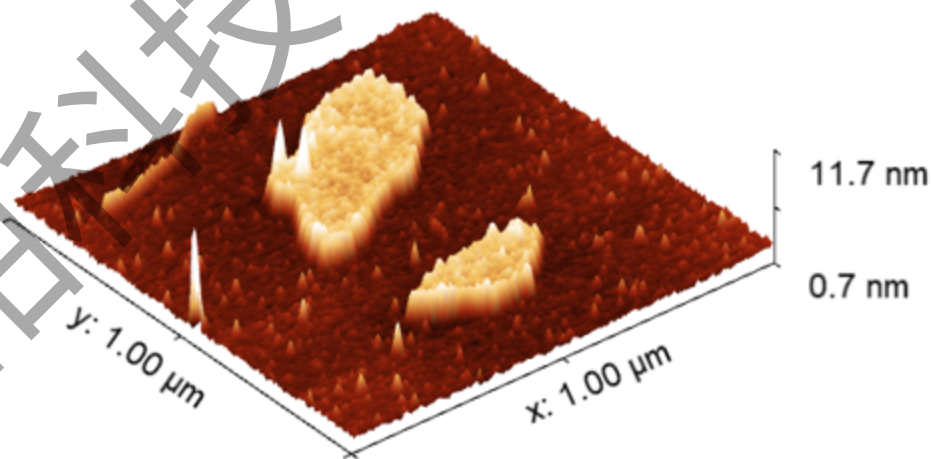
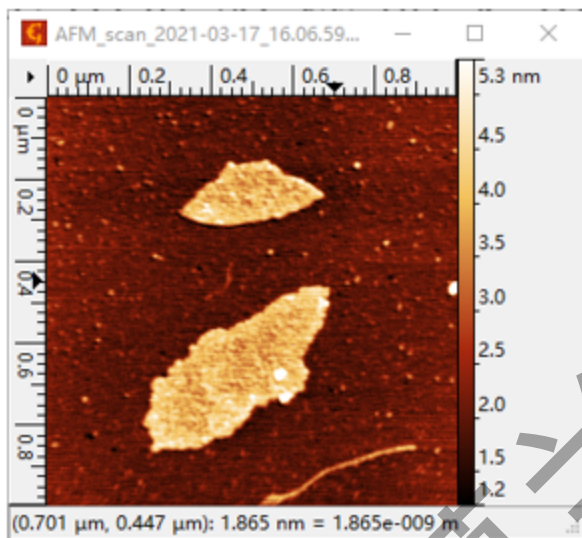


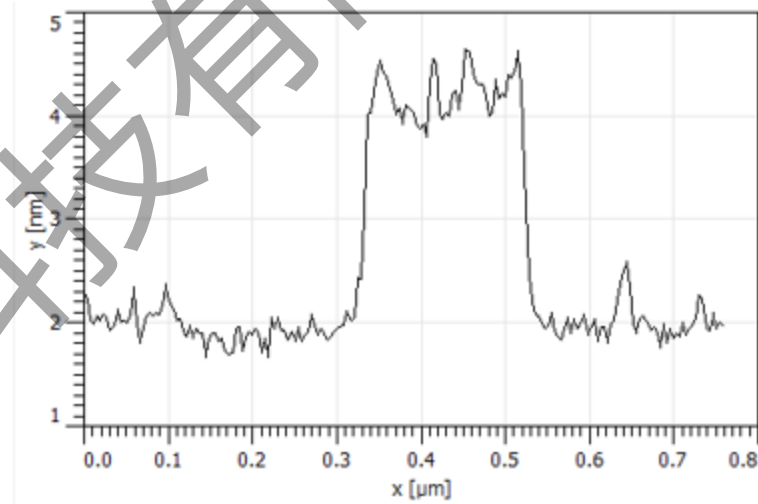
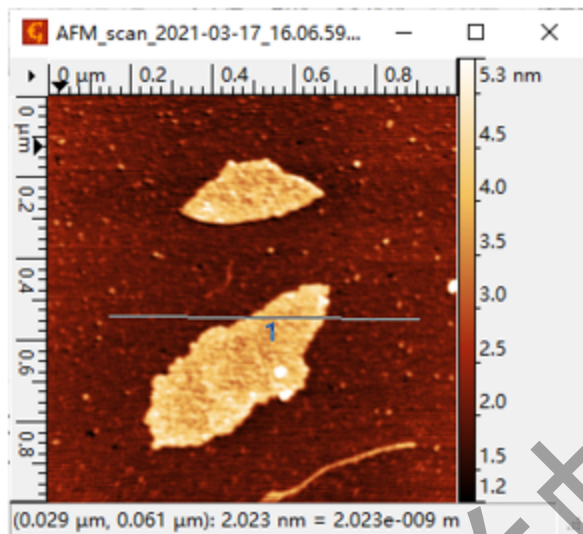
GO dot 2um

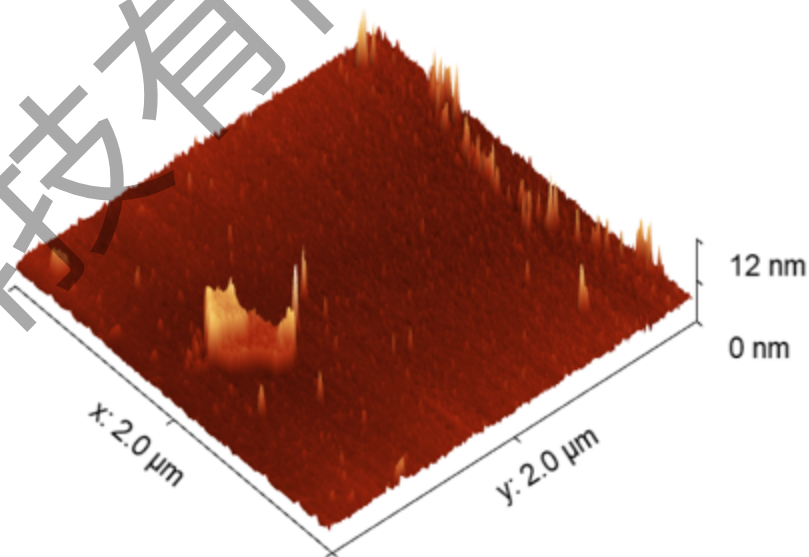
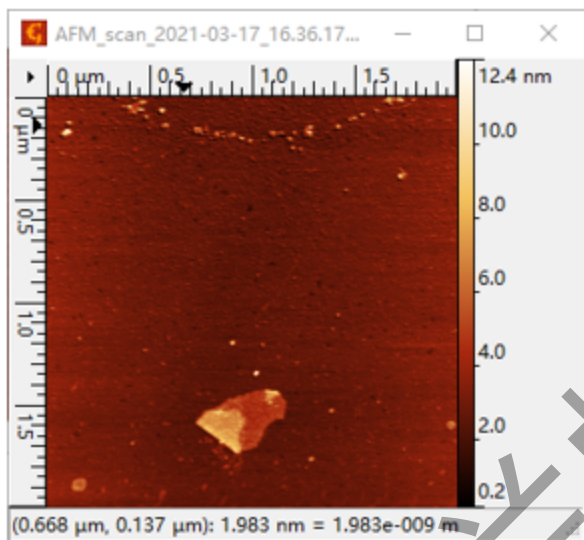


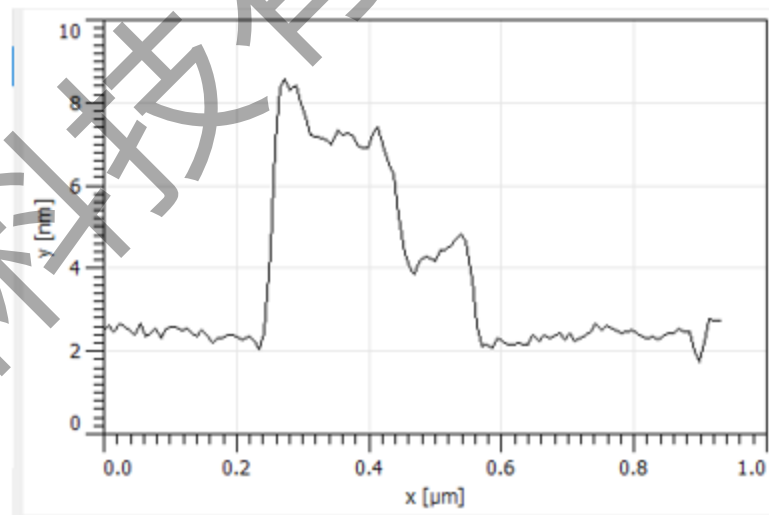
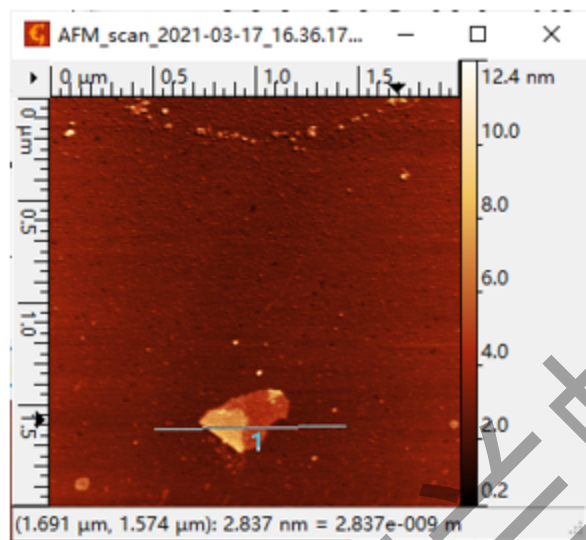
量子点高度为0.6nm

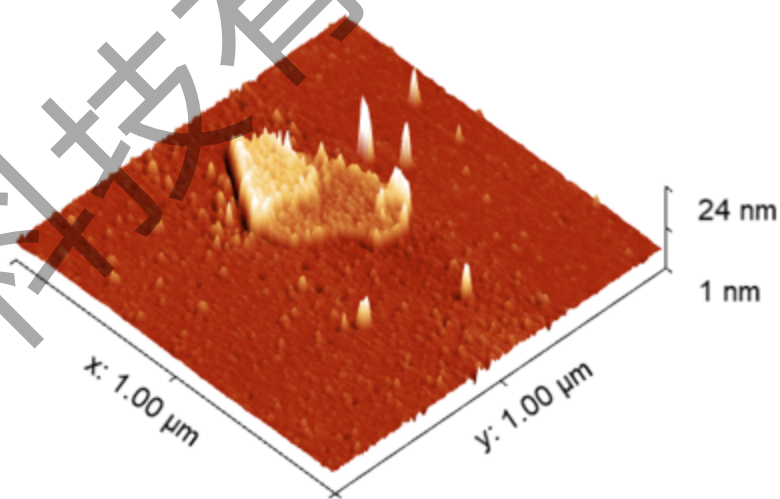
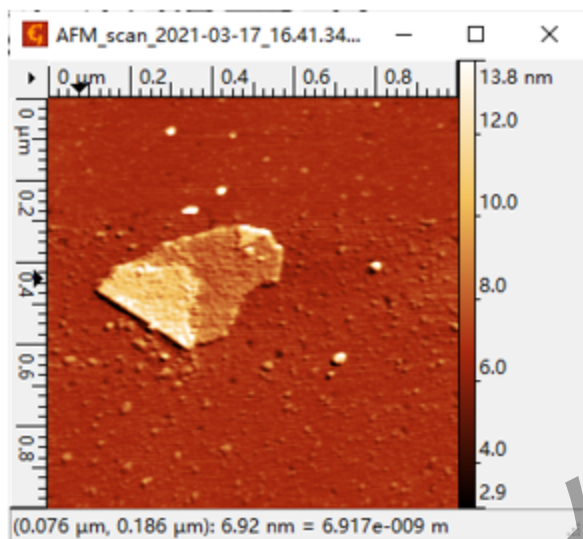
1um GO

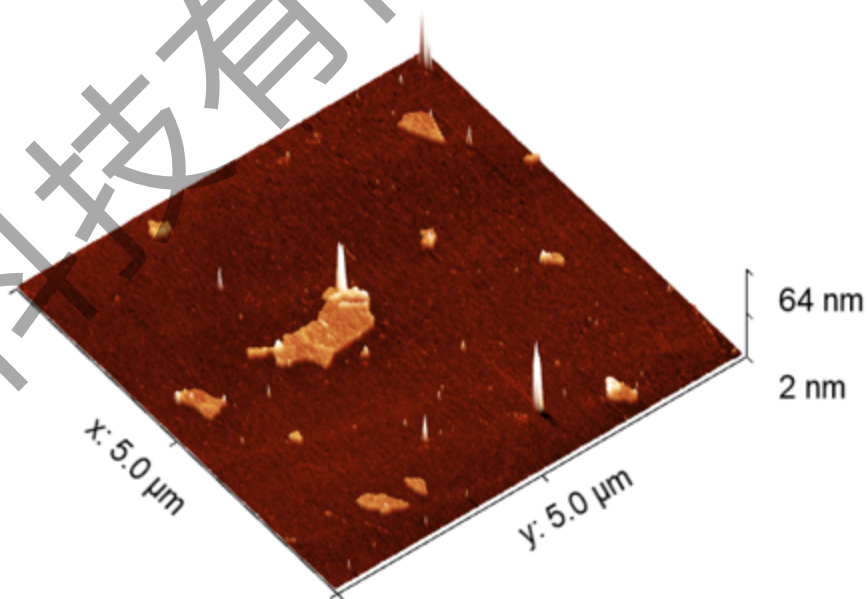
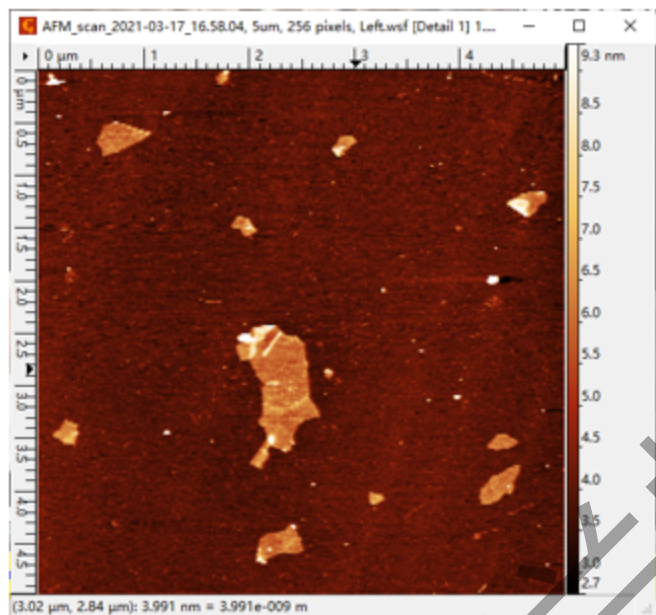


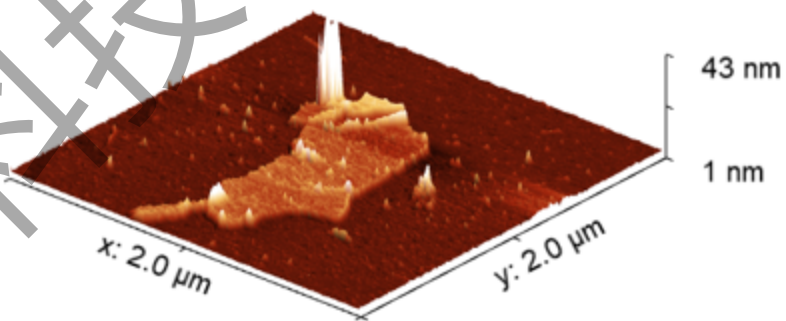
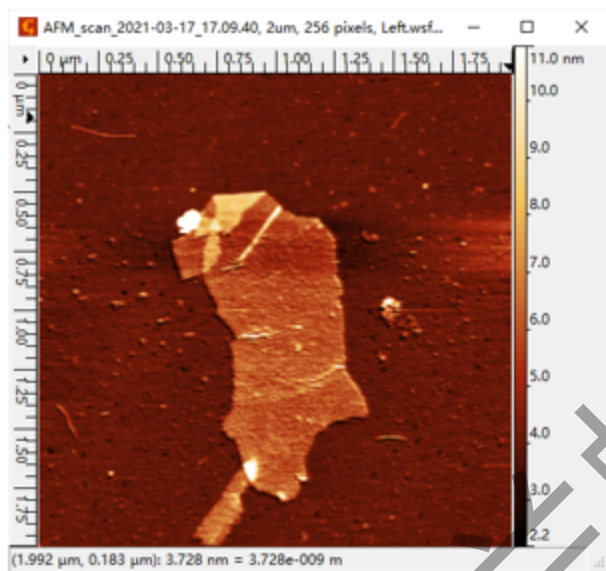


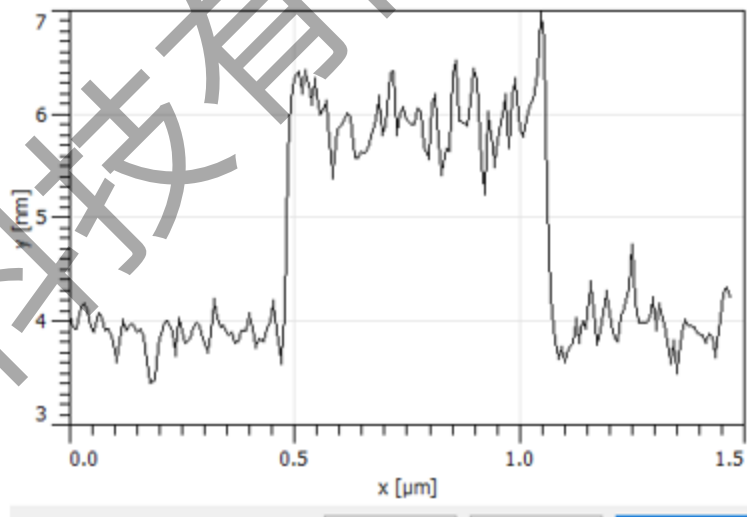
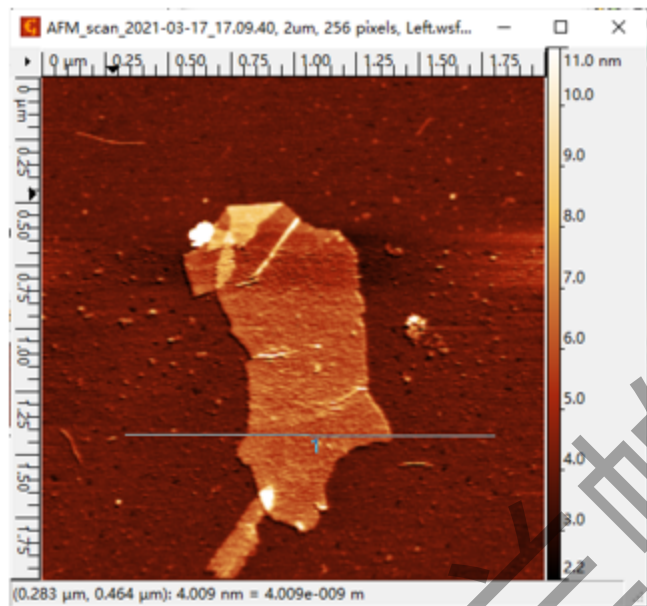


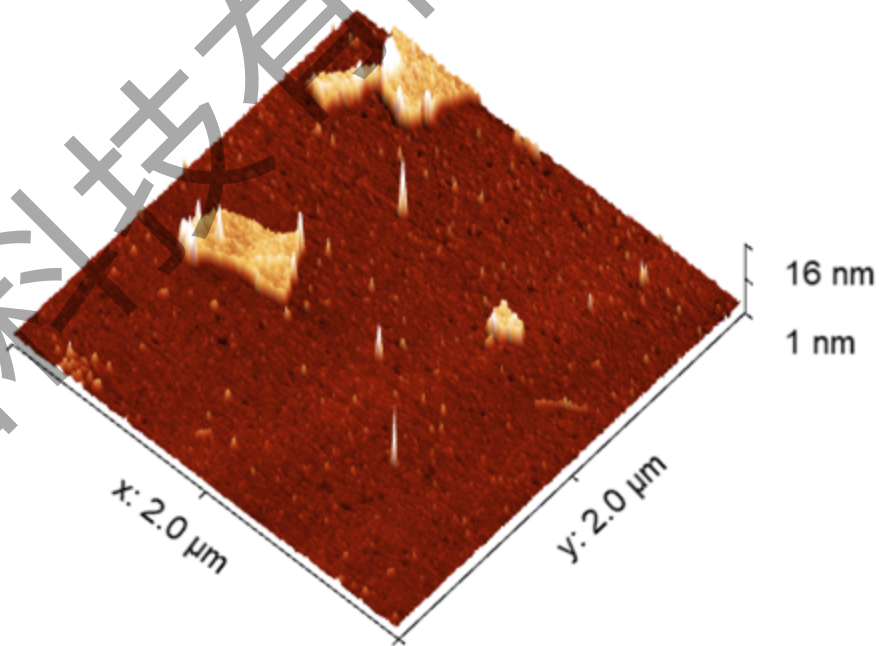
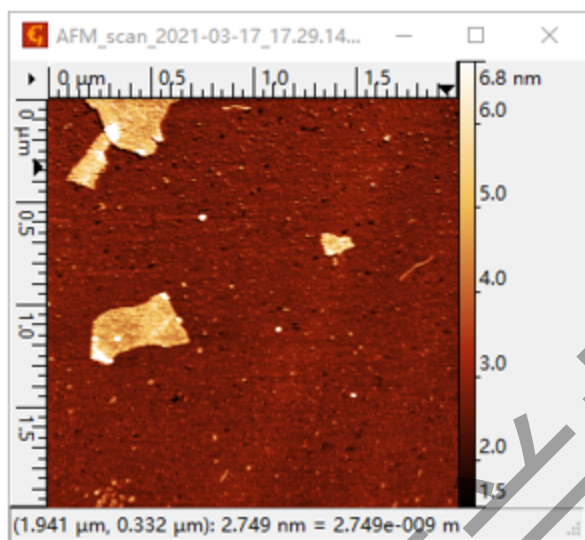


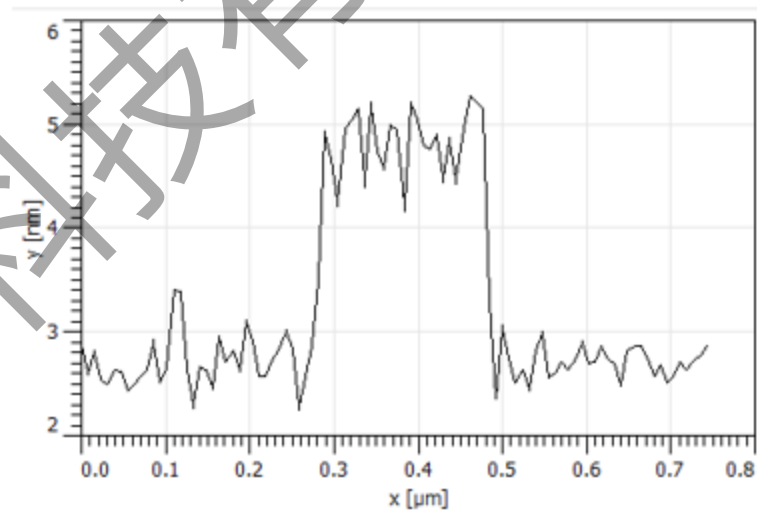
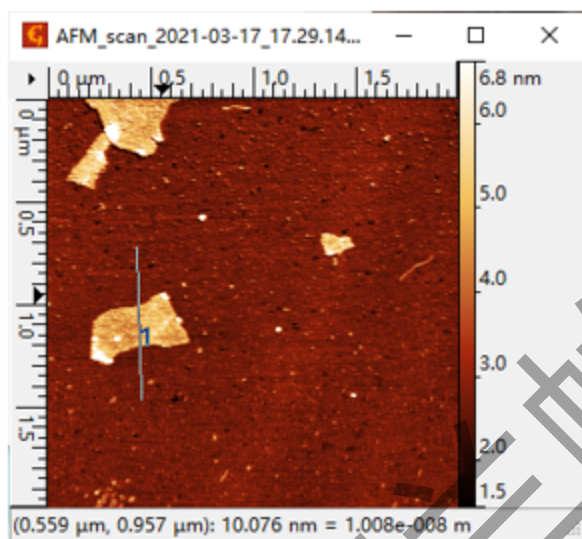


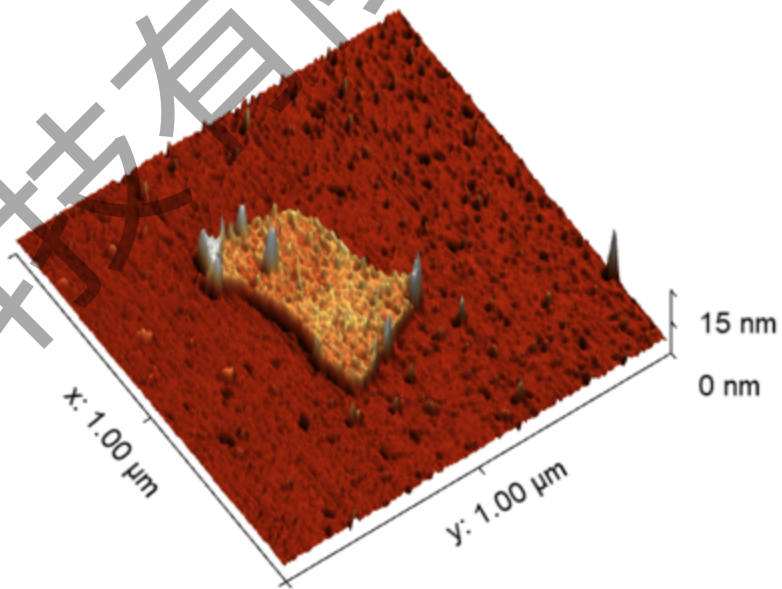
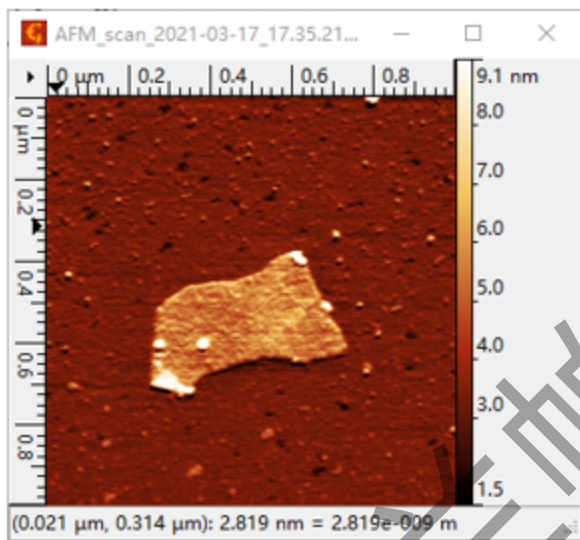


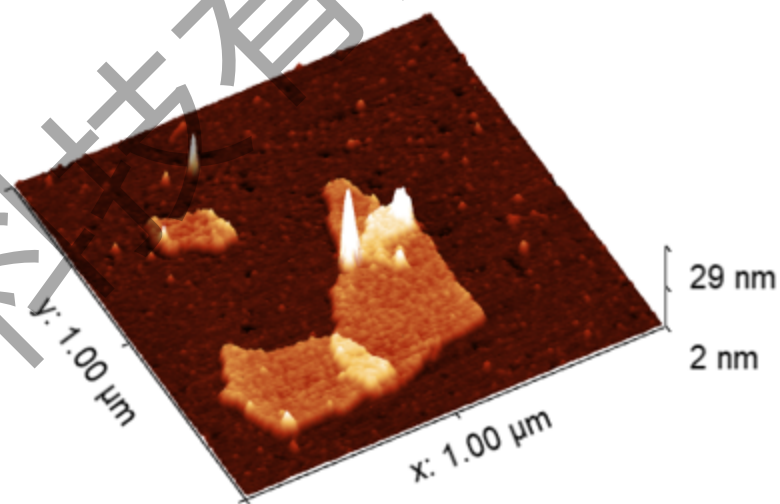
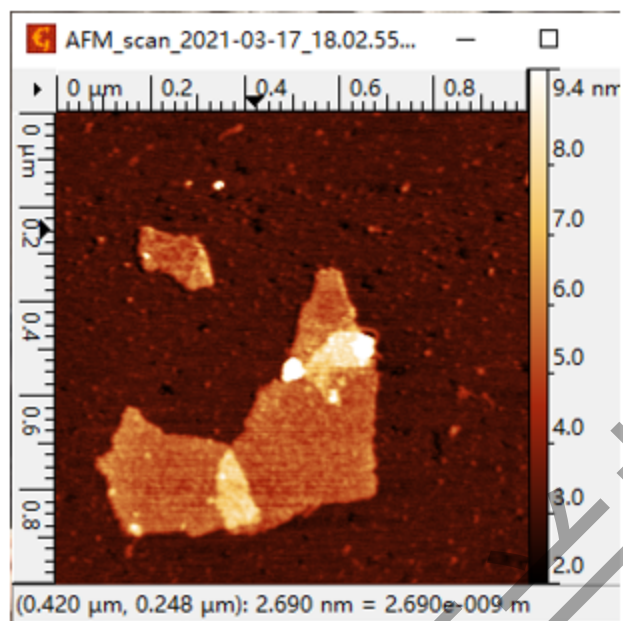


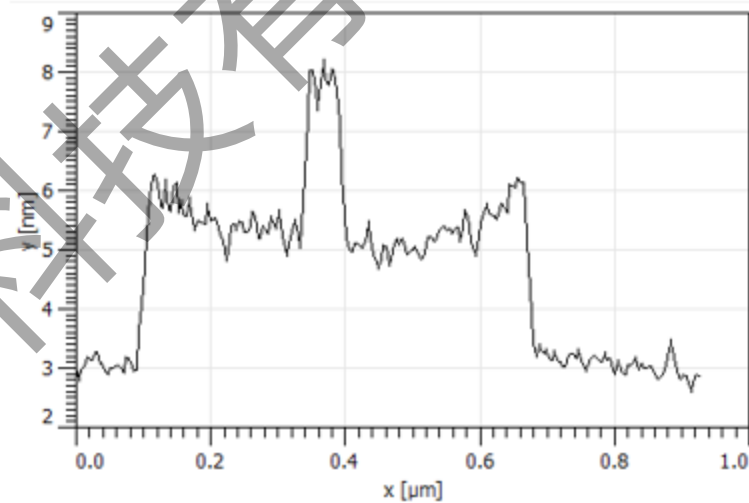
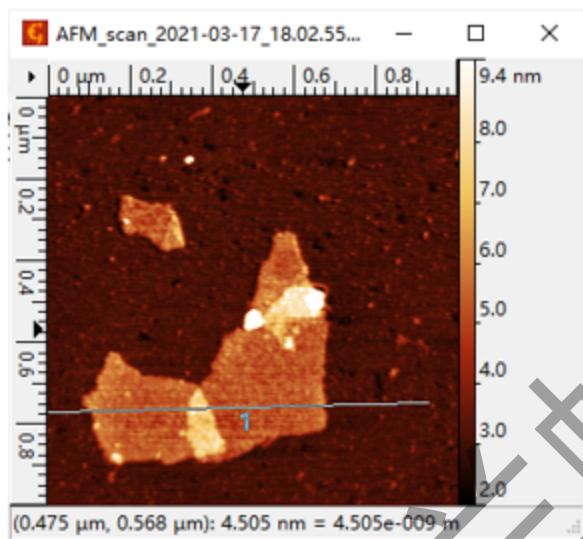


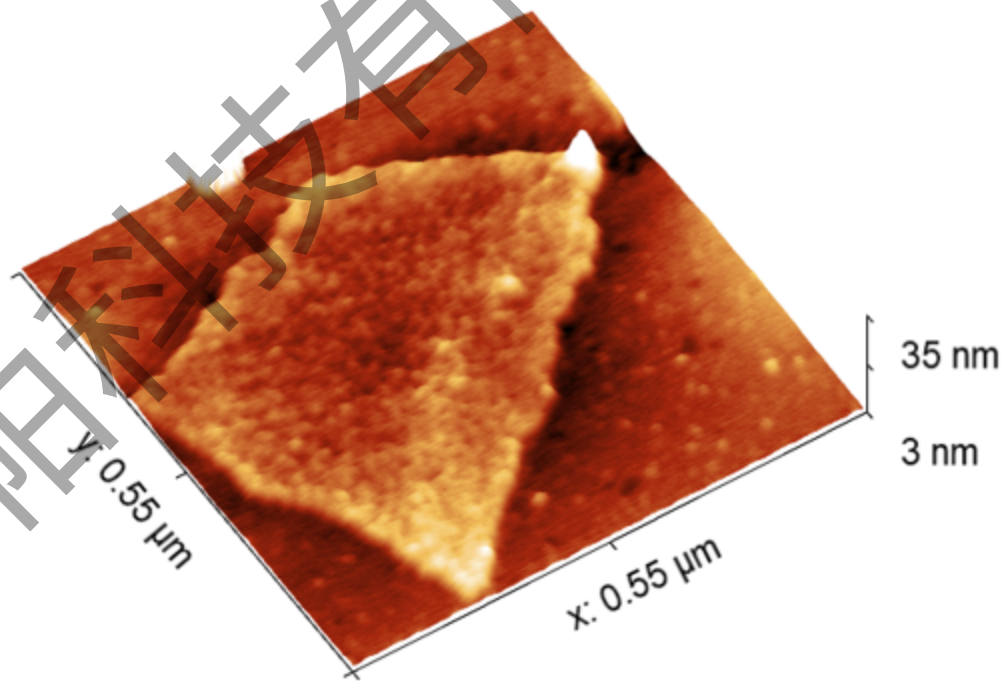
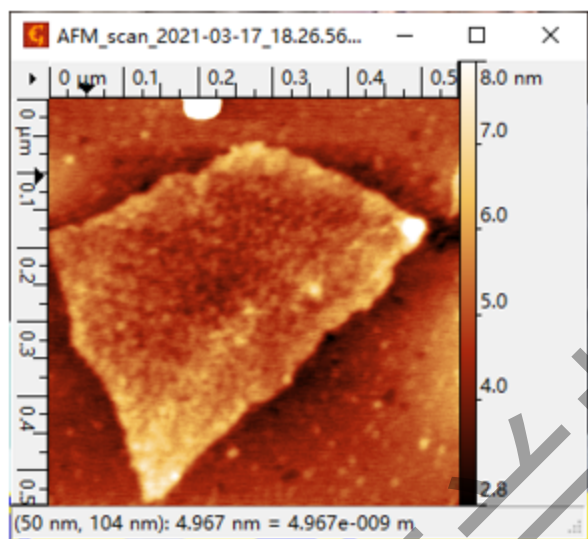


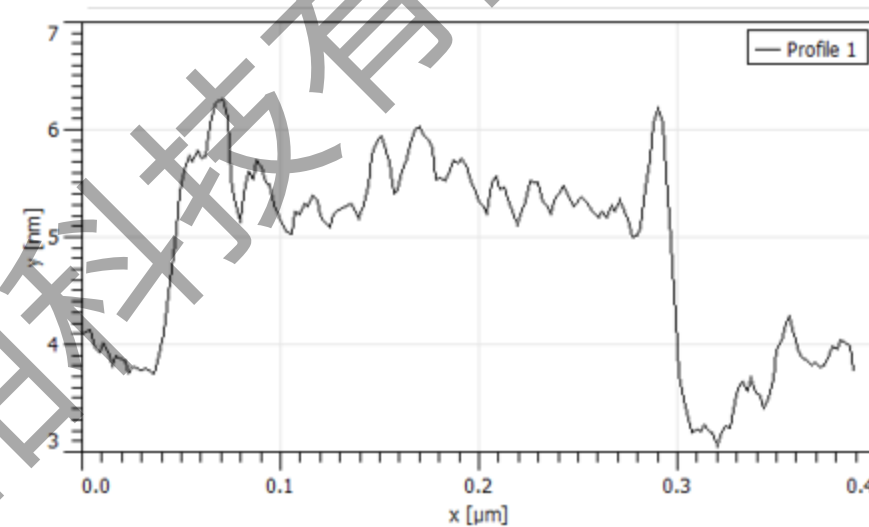
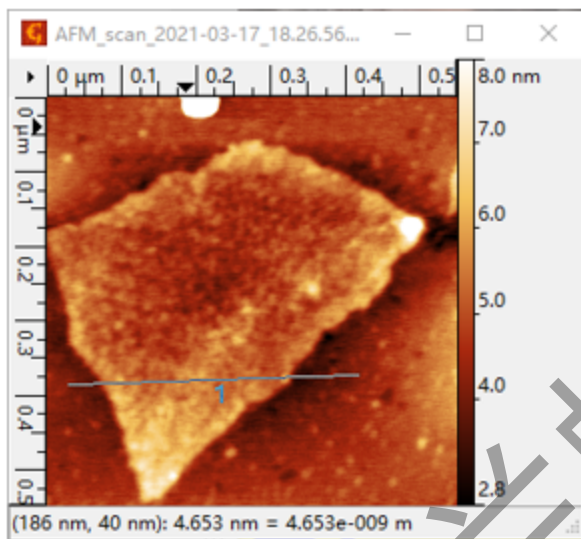












topographic on Go film

